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Indian Standard

# SPECIFICATION FOR FIXED INSULATED, HERMETICALLY SEALED TANTALUM CAPACITORS WITH SOLID ELECTROLYTE

## PART 2 TYPE FCST 1

Section 2 Non-Polar

- **0.** General This standard shall be read in conjunction with IS: 8507 (Part 1)-1977' Specification for fixed insulated hermetically sealed tantalum capacitors with solid electrolyte: Part 1 General requirements and methods of tests'.
- 1. Outline Drawing and Dimensions The outline drawing and dimensions shall be according to Fig. 1 and Table 1.

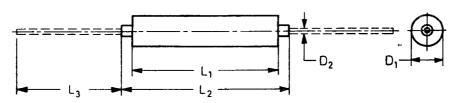


FIG. 1 NON-POLAR SOLID TANTALUM CAPACITOR

Note — Two equal values of polar capacitors with matched dc leakage current are connected back to back obtain a non-polar capacitor.

See 4.1 of IS: 8507 (Part 1) - 1977

#### 2. Ratings and Characteristics

Rated capacitance

Low air pressure

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b)	Selection tolerance	$\pm$ 5 percent; $\pm$ 10 percent; $\pm$ 20 percent	
c)	Rated voltage ( $U_r$ )	See Table 2	
d)	Category voltage ( U <sub>e</sub> )	See Table 2	
e)	Surge voltage ( $U_s$ )	See Table 2	
f)	Rated temperature	85°C	
g)	Vibration	10-2 000 Hz, 200 m/s² 3 x 4 h	
h)	Bump	4 000,400 m/s <sup>2</sup>	
j)	Shock	1 km/s <sup>2</sup>	
k)	Acceleration	1 km/s²	
m)	Climatic category	55/125/56 ( see Appendix A of IS: 589-1961 ) Basic climatic and mechanical durability tests for components for electronic and electrical equipment ( revised )	

2 kPa

#### TABLE 1 DIMENSIONS

(Clause 1)

#### All dimensions in millimetres

Case Size	L 1 ± 0·79 mm	L2 (Max)	L3 (Min)	D 1 + 0.41 - 0.38	<b>D</b> 2
(1)	(2)	(3)	(4)	(5)	(6)
AA	20.9	27:0	31.75	3.43	0·50 ± 0·05
ВВ	30.0	36.0	31.75	4.70	0.20 ± 0.02
cc	40.4	46*5	31.75	7:34	0.60 + 0.06 - 0.05
DD	45.8	51.8	31.75	8:92	0.60 + 0.06 - 0.02

# TABLE RATED VOLTAGE ( $U_R$ ), CATEGORY VOLTAGE ( $U_C$ ), AND SURGE VOLTAGE ( $U_S$ ) (Clause 2)

U <sub>R</sub> (at 85°C) ∨	U <sub>C</sub> ( at 125°C ) V	U <sub>S</sub> (at 85°C) V
(1)	(2)	(3)
6	10 10 10 10 10 10 10 10 10 10 10 10 10 1	8
10	7	13
15	10	20
20	13	26
35	23	46
50	33	65
75	50	98
100	67	130

- 3. Marking See 7 of IS: 8507 (Part 1) 1977.
- 4. Constructions and Workmanship See 5 of IS: 8507 (Part 1) 1977.
- 5. Classification of Tests See 8.1 of IS: 8507 (Part 1) 1977.
- 5.1 General Conditions for Tests See 8.2 of IS: 8507 (Part 1) 1977.
  - 5.1.1 The test schedule and requirements shall be in accordance with Table 3.

### TABLE 3 TEST SCHEDULE AND REQUIREMENTS

( Clause 5.1.1 )

		2.0	(	
SI No.	Test	Clause <b>Ref</b> in IS: 8507 ( Part 1 )-1977	Condition of Test	Requirement
(1)	(2)	(3)	(4)	(5)
i)	) All Samples :			
	a) Visual examination	8.4.1	_	The workmanship and finish shall be satisfactory. The marking shall be legible
	b) Dimensions	8.4.2	_	The dimensions of the capaci- tors and their terminations shall conform to values given in Table 1 used with Fig. 1
	c) Capacitance	8.3.2		The capacitance value shall correspond with the rated capacitance taking into account the tolerance
	d) Tangent of loss angle	8.3.3	_	The value shall not exceed:
				Rated Voltage Tan 8 V percent 6:3 and 10 8
				15 and 20 6 25 and 35 4
	e) Leakage current	8.3.1	<del>-</del> '.	Leakage current at 25 ± 2°C shall not exceed 0°04 μA per microfarad volt
	f) Voltage proof	8.3.4	_ ·	There shall be no breakdown or flashover
	g) Insulation resistance	8.3.5	_	Insulation resistance shall be not less than 1 000 M $\Omega_{\textrm{s}}$
	h) Sealing	8.4.10	<del></del>	There shall be no leakage of electrolyte and bubbling of gas when fully immersed in the solution
II)	First Group:			the solution
	a) Solderability	8.4.4	· . —	The tinning shall be uniform and good
	$\boldsymbol{b)} \ \ \boldsymbol{Robustness} \ \ \boldsymbol{of} \ terminations$	: 8.4.3	_	
	1) Visual examination	8.4,1	****	There shall be no damage
	c) Bump:	8.4.6	4 000, F 400 m/s <sup>2</sup>	<del>-</del>
	1) Visual examination	8.4.1		There shall be no damage
	2) Capacitance	8.3.2	_	The change in capacitance value from the value recorded in SI No. i(c) shall not exceed ± 2 percent
	3) Tangent of loss angle	8.3.3	. <del>-</del>	As per initial limits
	4) Leakage current	8.3.1	_	As per initial limits
٠.	d) Vibration:	8.4.5	19-2 900 Hz, 200 m/s <sup>2</sup> 3 x 4 h	_ **:
	1) Visual examination	8.4.1		There shall be no damage
	2) Capacitance	8.3.2	_	The change in capacitance value from the value recorded in SI No. i(c) shall not exceed ± 2 percent
	3) Tangent of loss angle	8.3,3		As per initial limits
*	4) Leakage current	8.3.1		As per initial limits (Continued

Test	Clause Ref in IS: 8507 (Part 1)-1977	Condition of Test	Requirement
(2)	(3)	(4)	(5)
e) Shock:	8.4.7	*****	
1) Visual examination	8.4.1	_	There shall be no damage
2) Capacitance	8.3.2	_	The change in capacitance value from the value recorded in SI No. I(c) shall not exceed ± 2 percent
3) Tangent of loss angle	8.3.3	_	As per initial limits
4) Leakage current	8.3.1		As per Initial limits
f) Acceleration (Steady state):	8.4.8	1 km/s² rigidly mounted using brackets	•
1) Visual examination	8.4.1	_	There shall be no damage
2) Capacitance	8.3.2	_	The change in capacitance value from the value recorder in Si No. i(c) shall not exceed ± 2 percent
3) Tangent of loss angle	8.3.3	<del></del>	As per initial limits
4) Leakage current	1.3.1	<del>-</del>	As per initial limits
g) Rapid change of temperature	<b>8.5.3</b>	_	
1) Visual examination	8.4.1	. <u>-</u>	There shall be no damage
2) Capacitance	8.3.2	_	The change in capacitance value from the value recorder in SI No. i(c) shall no exceed ±2 percent
3) Tangent of loss angle	8.3.3	NAMES OF THE PARTY	As per initial limits
4) Leakage current	8.3.1		As per initial limits
h) Climatic sequence:	8.5.1	~	_
1) Dry heat	8.5.1.2	At the maximum category temperature ( + 125°C ) for 16 h	
<ol><li>Damp heat (Accelerated) first cycle :</li></ol>	8.5.1. <b>3</b>	_	
<ol> <li>Visual examination</li> </ol>	8.4.1	-	There shall be no damage
3) Cold*:	8.5.1.4	At minimum category tempera- ture of ( —55°C ) for 2 h	
i) Visual examination	8.4.1		There shall be no damage
4) Low air pressure	8.5.1.5	2 kPa	There shall be no short circuit
<ol> <li>Damp heat (Accelerated) Remaining cycles:</li> </ol>	8.5.1.6	_	_
i) Visual examination	8.4.1		There shall be no damage
ii) Voltage proof	8.3.2		There shall be no breakdown or flashover
ili) Insulation resistance	8.3.5		1 000 MΩ, Min
iv) Capacitance	8.3.2	_	The change in capacitane value shall not exceed 土 percent
v) Tangent of loss angle	8.3.3		As per initial limits
vi) Leakage of current	8 <b>.3.</b> 1		As per initial limits

<sup>\*</sup>During the last 10 minutes of the period of exposure the rated voltage shall be applied to the specimens. No breakdown or flashover shall occur.

TABLE 3 TEST SCHEDULE AND REQUIREMENTS — Contd				
SI No.	Test	Clause Ref in IS : 8507 ( Part 1 ) - 1977	Condition of Test	Requirement
(1)	(2)	(3)	(4)	(5)
111)	Second Group:			
	a) Damp heat (long term):	8.5.2	To one half of the specimens rated voltage shall be applied	
	1) Visual examination	8.4.1		There shall be no damage
	2) Voltage proof	8.3.4	_	There shall be no breakdown or flashover
	3) Insulation resistance	8.3.5	<del></del>	1 000 MΩ, Min
	4) Capacitance	8.3.2	<del></del>	The change in capacitance value shall not exceed ± 2 percent
	5) Tangent of loss angle	8.3.3	_	As per initial limits
	6) Leakage current	8. <b>3.</b> 1	_	As per initial limits
IV)	Third Group:			
	a) Endurance:	8.7		
	1) Visual examination	8.4.1	_	There shall be no damage
	2) Capacitance	8.3.2	<del></del>	The change in capacitance value shall not exceed ± 2 percent
	3) Tangent of loss angle	8.3.3	_	As per initial limits
	4) Leakage current	8.3.1	_	As per initial limits
	5) Insulation resistance	8.3.5	_	1 000 MΩ, <i>Min</i>
V)	Fourth Group:			
	a) Mould growth	<b>8.</b> 5. <b>5</b>	_	There shall be no mould growth
VI)	Fifth Group:			
	a) Resistance to soldering heat	8.4.4.2	_	-
	1) Capacitance	8,3.2		The change in capicitance value from the value recorded in SI No. i(c) shall not exceed 土 5 percent
	2) Tangent of loss angle	8.3.3	<del>-</del>	As per initial limits
	3) Leakage current	8.3.1	<del>-</del>	As per initial limits
:	b) Resistance to solvents	8.4.9	_	
	1) Visual examination	8.4.1	_	The marking shall be legible and shall not rub off. There shall be no damage
VII)	Sixth Group:			
i	a) Characteristics at low and high temperature	8.6	_	<del>_</del>
(	Step 1 ) at 25°C :		-	
	1) Capacitance	8.3.2		As per initial limits
	2) Tangent of loss angle	8.3.3	_	As per initial limits
(,	Step 2 ) at — 55°C :		_	_
	Capacitance     Tangent of loss angle	8.3.2 8.3.3	<del></del>	The change in capacitance value shall not exceed ± 10 percent from the value recorded at step 1
	2) Tangent of 1088 angle	0,0,0	_	As per initial limits (Continued)

	TABLE 3 TEST SCHEDULE AND REQUIREMENTS — Contd				
Si No.	Tes	Clause Ref in IS: 8507 ( Part 1 )-1977	Condition of Test	Requirement	
(1)	(2)	(3)	(4)	(5)	
	( Step 3 ) at 25°C :				
	1) Capacitance	8.3.2		The change in capacitance value shall not exceed ± 2 percent from the value recorded at step 1	
	2) Tangent of loss angle	8.3.3	•••••	As per initial limits	
	3) Leakage current	8.3.1	-	As per initial ilmits	
	(Step 4) at + 85°C:				
	1) Capacitance	8.3.2	_	The change in capacitance value shall not exceed ± 8 percent from the value recorded at step 1	
	2) Tangent of loss angle	8.3.3		As per initial limits	
	3) Leakage current	8.3.1	The category voltage shall be applied	As per initial limits	
	(Step 5) at + 125°C:				
	1) Capacitance	8.3.2	_	The change in capacitance value shall not exceed ± 12 percent from the value recorded at step 1	
	2) Tangent of loss angle	8.3,3		As per initial limits	
	3) Leakage current	8.3.1	-	As per initial limits	
	b) Surge :	8.8	*****	_	
	1) Visual examination	8.4.1		There shall be no damage	
	2) Capacitance	8.3.2	_	The change in capacitance value shall not exceed $\pm$ percent	
	3) Tangent of loss angle	8.3.3	_	As per initial limits	
	4) Leakage current	8.3.1	_	As per initial limits	
	c) Salt mist:	8.5.4	4 days		
	1) Visual examination	8.4.1	_	There shall be no corrosion or any other damage	